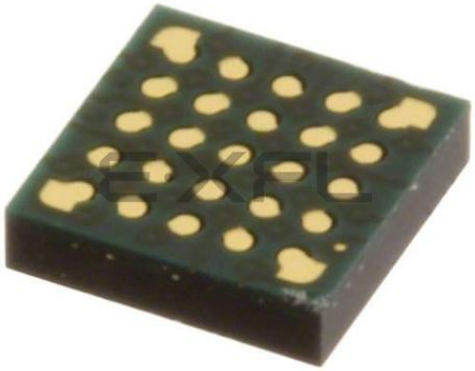
Renesas Electronics America Inc - R5F10E8AALA#U0 Datasheet



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What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "Embedded - Microcontrollers"

Details	
Product Status	Active
Core Processor	RL78
Core Size	16-Bit
Speed	32MHz
Connectivity	CSI, I²C, LINbus, UART/USART
Peripherals	DMA, LVD, POR, PWM, WDT
Number of I/O	14
Program Memory Size	16KB (16K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	2K x 8
Voltage - Supply (Vcc/Vdd)	1.6V ~ 3.6V
Data Converters	A/D 13x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	25-WFLGA
Supplier Device Package	25-LGA (3x3)
Purchase URL	https://www.e-xfl.com/product-detail/renesas-electronics-america/r5f10e8aala-u0

(2/2)

Item		25-pin R5F10E8x	32-pin R5F10EBx	48-pin R5F10EGx	64-pin R5F10ELx
Clock output/buzzer output		1	2	2	2
		• 2.44 kHz, 4.88 kHz, 9.76 kHz, 1.25 MHz, 2.5 MHz, 5 MHz, 10 MHz (Main system clock: f_{MAIN} = 20 MHz operation)		• 2.44 kHz, 4.88 kHz, 9.76 kHz, 1.25 MHz, 2.5 MHz, 5 MHz, 10 MHz (Main system clock: f_{MAIN} = 20 MHz operation) • 256 Hz, 512 Hz, 1.024 kHz, 2.048 kHz, 4.096 kHz, 8.192 kHz, 16.384 kHz, 32.768 kHz (Subsystem clock: f_{SUB} = 32.768 kHz operation)	
8/12-bit resolution A/D converter		13 channels	18 channels	24 channels	28 channels
Serial interface		[25-pin products] • CSI: 1 channel/simplified I^2C: 1 channel/UART: 1 channel • CSI: 1 channel/simplified I^2C: 1 channel/UART: 1 channel [32-pin products] • CSI: 1 channel/simplified I^2C: 1 channel/UART: 1 channel • CSI: 1 channel/simplified I^2C: 1 channel/UART: 1 channel • CSI: 1 channel/simplified I^2C: 1 channel/UART (UART supporting LIN-bus): 1 channel [48-pin products] • CSI: 2 channels/simplified I^2C: 2 channels/UART: 1 channel • CSI: 1 channel/simplified I^2C: 1 channel/UART: 1 channel • CSI: 2 channels/simplified I^2C: 2 channels/UART (UART supporting LIN-bus): 1 channel [64-pin products] • CSI: 2 channels/simplified I^2C: 2 channels/UART: 1 channel • CSI: 2 channels/simplified I^2C: 2 channels/UART: 1 channel • CSI: 2 channels/simplified I^2C: 2 channels/UART (UART supporting LIN-bus): 1 channel			
	I^2C bus	1 channel	1 channel	1 channel	1 channel
Multiplier and divider/multiply-accumulator		• 16 bits × 16 bits = 32 bits (Unsigned or signed) • 32 bits ÷ 32 bits = 32 bits (Unsigned) • 16 bits × 16 bits + 32 bits = 32 bits (Unsigned or signed)			
DMA controller		2 channels			
Vectored interrupt sources	Internal	24	27	27	27
	External	6	6	10	13
Key interrupt		0 ch (4 ch)Note 1	1 ch (6 ch)Note 1	6 ch	10 ch
Reset		• Reset by $\overline{\text{RESET}}$ pin • Internal reset by watchdog timer • Internal reset by power-on-reset • Internal reset by voltage detector • Internal reset by illegal instruction executionNote 2 • Internal reset by RAM parity error • Internal reset by illegal-memory access			
Power-on-reset circuit		• Power-on-reset: 1.51 V (TYP.) • Power-down-reset: 1.50 V (TYP.)			
Voltage detector		• Rising edge : 1.67 V to 3.14 V (12 stages) • Falling edge : 1.63 V to 3.06 V (12 stages)			
On-chip debug function		Provided			
Power supply voltage		V_{DD} = 1.6 to 3.6 V			
Operating ambient temperature		T_A = −40 to +85°C (A: Consumer application), T_A = −40 to +105°C (G: Industrial application)			

Notes 1. Can be used by the Peripheral I/O redirection register (PIOR).

2. The illegal instruction is generated when instruction code FFH is executed.
Reset by the illegal instruction execution not issued by emulation with the in-circuit emulator or on-chip debug emulator.

2.2 Oscillator Characteristics

2.2.1 X1, XT1 oscillator characteristics

(T_A = –40 to +85°C, 1.6 V ≤ V_{DD} ≤ 3.6 V, V_{SS} = 0 V)

Parameter	Resonator	Conditions	MIN.	TYP.	MAX.	Unit
X1 clock oscillation frequency (f_X)Note	Ceramic resonator/crystal resonator	2.7 V ≤ V_{DD} ≤ 3.6 V	1.0		20.0	MHz
		2.4 V ≤ V_{DD} < 2.7 V	1.0		16.0	MHz
		1.8 V ≤ V_{DD} < 2.4 V	1.0		8.0	MHz
		1.6 V ≤ V_{DD} < 1.8 V	1.0		4.0	MHz
XT1 clock oscillation frequency (f_X)Note	Crystal resonator		32	32.768	35	kHz

Note Indicates only permissible oscillator frequency ranges. See AC Characteristics for instruction execution time. Request evaluation by the manufacturer of the oscillator circuit mounted on a board to check the oscillator characteristics.

<R> **Caution Since the CPU is started by the high-speed on-chip oscillator clock after a reset release, check the X1 clock oscillation stabilization time using the oscillation stabilization time counter status register (OSTC) by the user. Determine the oscillation stabilization time of the OSTC register and the oscillation stabilization time select register (OSTS) after sufficiently evaluating the oscillation stabilization time with the resonator to be used.**

2.2.2 On-chip oscillator characteristics

(T_A = –40 to +85°C, 1.6 V ≤ V_{DD} ≤ 3.6 V, V_{SS} = 0 V)

Oscillators	Parameters	Conditions		MIN.	TYP.	MAX.	Unit
High-speed on-chip oscillator clock frequencyNotes 1, 2	f_{IH}			1		32	MHz
High-speed on-chip oscillator clock frequency accuracy		–20 to +85 °C	1.8 V ≤ V_{DD} ≤ 3.6 V	–1.0		+1.0	%
			1.6 V ≤ V_{DD} < 1.8 V	–5.0		+5.0	%
		–40 to –20 °C	1.8 V ≤ V_{DD} ≤ 3.6 V	–1.5		+1.5	%
			1.6 V ≤ V_{DD} < 1.8 V	–5.5		+5.5	%
Low-speed on-chip oscillator clock frequency	f_{IL}				15		kHz
Low-speed on-chip oscillator clock frequency accuracy				–15		+15	%

Notes 1. High-speed on-chip oscillator frequency is selected by bits 0 to 3 of option byte (000C2H/010C2H) and bits 0 to 2 of HOCODIV register.

2. This indicates the oscillator characteristics only. See AC Characteristics for instruction execution time.

2.3 DC Characteristics

2.3.1 Pin characteristics

(T_A = –40 to +85°C, 1.6 V ≤ AV_{DD} ≤ V_{DD} ≤ 3.6 V, 1.6 V ≤ EV_{DD0} ≤ V_{DD} ≤ 3.6 V, V_{SS} = EV_{SS0} = 0 V) **(1/5)**

Items	Symbol	Conditions		MIN.	TYP.	MAX.	Unit
Output current, high[Note 1]	I_{OH1}	Per pin for P00 to P06, P10 to P16, P30, P31, P40 to P43, P50, P51, P70 to P77, P120, P130, P140, P141	1.6 V ≤ EV_{DD0} ≤ 3.6 V			–10.0[Note 2]	mA
		Total of P00 to P04, P40 to P43, P120, P130, P140, P141 (When duty ≤ 70%[Note 3])	2.7 V ≤ EV_{DD0} ≤ 3.6 V			–10.0	mA
			1.8 V ≤ EV_{DD0} < 2.7 V			–5.0	mA
			1.6 V ≤ EV_{DD0} < 1.8 V			–2.5	mA
		Total of P05, P06, P10 to P16, P30, P31, P50, P51, P70 to P77, (When duty ≤ 70%[Note 3])	2.7 V ≤ EV_{DD0} ≤ 3.6 V			–19.0	mA
			1.8 V ≤ EV_{DD0} < 2.7 V			–10.0	mA
			1.6 V ≤ EV_{DD0} < 1.8 V			–5.0	mA
		Total of all pins (When duty ≤ 70%[Note 3])	1.6 V ≤ EV_{DD0} ≤ 3.6 V			–29.0	mA
	I_{OH2}	Per pin for P20 to P27, P150 to P154	1.6 V ≤ AV_{DD} ≤ 3.6 V			–0.1[Note 2]	mA
		Total of all pins (When duty ≤ 70%[Note 3])	1.6 V ≤ AV_{DD} ≤ 3.6 V			–1.3	mA

Notes 1. Value of current at which the device operation is guaranteed even if the current flows from the EV_{DD0}, V_{DD} pins to an output pin.

2. However, do not exceed the total current value.

3. Specification under conditions where the duty factor ≤ 70%.
The output current value that has changed to the duty factor > 70% the duty ratio can be calculated with the following expression (when changing the duty factor from 70% to n%).

- Total output current of pins = (I_{OH} × 0.7)/(n × 0.01)

<Example> Where n = 80% and I_{OH} = –10.0 mA
Total output current of pins = (–10.0 × 0.7)/(80 × 0.01) ≅ –8.7 mA

However, the current that is allowed to flow into one pin does not vary depending on the duty factor. A current higher than the absolute maximum rating must not flow into one pin.

Caution P00, P02 to P04, P10 to P15, P43, P50, P71, and P74 do not output high level in N-ch open-drain mode.

Remark Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.

(4) During communication at same potential (CSI mode) (slave mode, SCKp... external clock input)

(T_A = –40 to +85°C, 1.6 V ≤ EV_{DD0} ≤ V_{DD} ≤ 3.6 V, V_{SS} = EV_{SS0} = 0 V)

Parameter	Symbol	Conditions		HS[Note 1]		LS[Note 2]		LV[Note 3]		Unit
				MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
SCKp cycle time[Note 4]	t_{KCY2}	2.7 V ≤ EV_{DD0} ≤ 3.6 V	16 MHz < f_{MCK}	8/f_{MCK}		–		–		ns
			f_{MCK} ≤ 16 MHz	6/f_{MCK}		6/f_{MCK}		6/f_{MCK}		ns
		2.4 V ≤ EV_{DD0} ≤ 3.6 V		6/f_{MCK} and 500ns		6/f_{MCK} and 500ns		6/f_{MCK} and 500ns		ns
		1.8 V ≤ EV_{DD0} ≤ 3.6 V		6/f_{MCK} and 750ns		6/f_{MCK} and 750ns		6/f_{MCK} and 750ns		ns
		1.7 V ≤ EV_{DD0} ≤ 3.6 V		6/f_{MCK} and 1500ns		6/f_{MCK} and 1500ns		6/f_{MCK} and 1500ns		ns
		1.6 V ≤ EV_{DD0} ≤ 3.6 V		–		6/f_{MCK} and 1500ns		6/f_{MCK} and 1500ns		ns
SCKp high-/low-level width	t_{KH2}, t_{KL2}	2.7 V ≤ EV_{DD} ≤ 3.6 V		t_{KCY2}/2 –8		t_{KCY2}/2 –8		t_{KCY2}/2 –8		ns
		1.8 V ≤ EV_{DD0} ≤ 3.6 V		t_{KCY2}/2 –18		t_{KCY2}/2 –18		t_{KCY2}/2 –18		ns
		1.7 V ≤ EV_{DD0} ≤ 3.6 V		t_{KCY2}/2 –66		t_{KCY2}/2 –66		t_{KCY2}/2 –66		ns
		1.6 V ≤ EV_{DD0} ≤ 3.6 V		–		t_{KCY2}/2 –66		t_{KCY2}/2 –66		ns
SIp setup time (to SCKp↑)[Note 5]	t_{SIK2}	2.7 V ≤ EV_{DD0} ≤ 3.6 V		1/f_{MCK} +20		1/f_{MCK} +30		1/f_{MCK} +30		ns
		1.8 V ≤ EV_{DD0} ≤ 3.6 V		1/f_{MCK} +30		1/f_{MCK} +30		1/f_{MCK} +30		ns
		1.7 V ≤ EV_{DD0} ≤ 3.6 V		1/f_{MCK} +40		1/f_{MCK} +40		1/f_{MCK} +40		ns
		1.6 V ≤ EV_{DD0} ≤ 3.6 V		–		1/f_{MCK} +40		1/f_{MCK} +40		ns
SIp hold time (from SCKp↑)[Note 5]	t_{KSI2}	1.8 V ≤ EV_{DD0} ≤ 3.6 V		1/f_{MCK} +31		1/f_{MCK} +31		1/f_{MCK} +31		ns
		1.7 V ≤ EV_{DD0} ≤ 3.6 V		1/f_{MCK}+ 250		1/f_{MCK}+ 250		1/f_{MCK}+ 250		ns
		1.6 V ≤ EV_{DD0} ≤ 3.6 V		–		1/f_{MCK}+ 250		1/f_{MCK}+ 250		ns
Delay time from SCKp↓ to SOp output[Note 6]	t_{KSO2}	C = 30 pF[Note 7]	2.7 V ≤ EV_{DD0} ≤ 3.6 V		2/f_{MCK} +44		2/f_{MCK} +110		2/f_{MCK} +110	ns
			2.4 V ≤ EV_{DD0} ≤ 3.6 V		2/f_{MCK} +75		2/f_{MCK} +110		2/f_{MCK} +110	ns
			1.8 V ≤ EV_{DD0} ≤ 3.6 V		2/f_{MCK} +110		2/f_{MCK} +110		2/f_{MCK} +110	ns
			1.7 V ≤ EV_{DD0} ≤ 3.6 V		2/f_{MCK} +220		2/f_{MCK} +220		2/f_{MCK} +220	ns
			1.6 V ≤ EV_{DD0} ≤ 3.6 V		–		2/f_{MCK} +220		2/f_{MCK} +220	ns

(**Note, Caution** and **Remark** are listed on the next page.)

(5) During communication at same potential (simplified I^2C mode) (2/2)

(T_A = –40 to +85°C, 1.6 V ≤ EV_{DD0} ≤ V_{DD} ≤ 3.6 V, V_{SS} = EV_{SS0} = 0 V)

Parameter	Symbol	Conditions	HS[Note 1]		LS[Note 2]		LV[Note 3]		Unit
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
Data hold time (transmission)	$t_{HD:DAT}$	2.7 V ≤ EV_{DD0} ≤ 3.6 V, C_b = 50 pF, R_b = 2.7 kΩ	0	305	0	305	0	305	ns
		1.8 V ≤ EV_{DD0} ≤ 3.6 V, C_b = 100 pF, R_b = 3 kΩ	0	355	0	355	0	355	ns
		1.8 V ≤ EV_{DD0} < 2.7 V, C_b = 100 pF, R_b = 5 kΩ	0	405	0	405	0	405	ns
		1.7 V ≤ EV_{DD0} ≤ 1.8 V, C_b = 100 pF, R_b = 5 kΩ	0	405	0	405	0	405	ns
		1.6 V ≤ EV_{DD0} < 1.8 V, C_b = 100 pF, R_b = 5 kΩ	–	–	0	405	0	405	ns

Notes 1. HS is condition of HS (high-speed main) mode.

2. LS is condition of LS (low-speed main) mode.

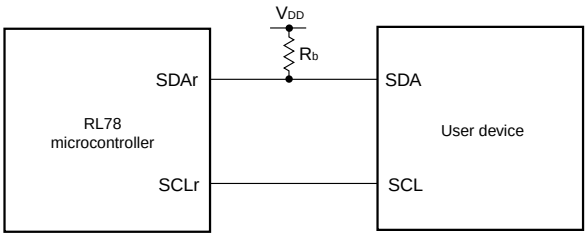
3. LV is condition of LV (low-voltage main) mode.

4. The value must also be f_{CLK}/4 or lower.

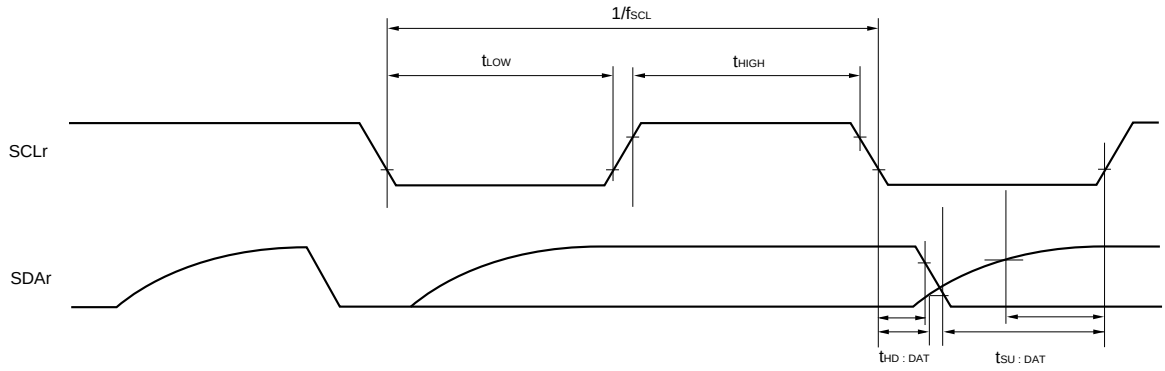
5. Set the f_{MCK} value to keep the hold time of SCLr = “L” and SCLr = “H”.

Caution Select the normal input buffer and the N-ch open drain output (V_{DD} tolerance (When 25- to 48-pin products)/EV_{DD} tolerance (When 64-pin products)) mode for the SDAr pin and the normal output mode for the SCLr pin by using port input mode register g (PIMg) and port output mode register h (POMh).

Simplified I^2C mode mode connection diagram (during communication at same potential)



Simplified I^2C mode serial transfer timing (during communication at same potential)

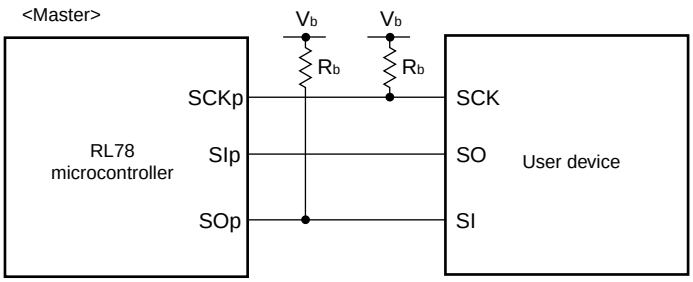


Remarks 1. R_b[Ω]: Communication line (SDAr) pull-up resistance, C_b[F]: Communication line (SDAr, SCLr) load capacitance

2. r: IIC number (r = 00, 01, 10, 11, 20, 21), g: PIM number (g = 0, 1), h: POM number (h = 0, 1)

3. f_{MCK}: Serial array unit operation clock frequency
(Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number, n: Channel number, mn = 00 to 03, 10, 11)

CSI mode connection diagram (during communication at different potential)



Remarks 1. R_b[Ω]: Communication line (SCKp, SOp) pull-up resistance, C_b[F]: Communication line (SCKp, SOp) load capacitance, V_b[V]: Communication line voltage

2. p: CSI number (p = 00, 10, 20), m: Unit number , n: Channel number (mn = 00, 02, 10), g: PIM and POM number (g = 0, 1)

3. CSI01, CSI11, and CSI21 cannot communicate at different potential. Use other CSI for communication at different potential.

(9) Communication at different potential (1.8 V, 2.5 V) (CSI mode) (slave mode, SCKp... external clock input)
(T_A = –40 to +85°C, 1.8 V ≤ EV_{DD0} ≤ V_{DD} ≤ 3.6 V, V_{SS} = EV_{SS0} = 0 V)

Parameter	Symbol	Conditions		HS[Note 1]		LS[Note 2]		LV[Note 3]		Unit
				MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
SCKp cycle time[Note 4]	t_{KCY2}	2.7 V ≤ EV_{DD0} ≤ 3.6 V, 2.3 V ≤ V_b ≤ 2.7 V	24 MHz < f_{MCK}	20/f_{MCK}		–		–		ns
			20 MHz < f_{MCK} ≤ 24 MHz	16/f_{MCK}		–		–		ns
			16 MHz < f_{MCK} ≤ 20 MHz	14/f_{MCK}		–		–		ns
			8 MHz < f_{MCK} ≤ 16 MHz	12/f_{MCK}		–		–		ns
			4 MHz < f_{MCK} ≤ 8 MHz	8/f_{MCK}		16/f_{MCK}		–		ns
			f_{MCK} ≤ 4 MHz	6/f_{MCK}		10/f_{MCK}		10/f_{MCK}		ns
		1.8 V ≤ EV_{DD0} < 3.3 V, 1.6 V ≤ V_b ≤ 2.0 V[Note 5]	24 MHz < f_{MCK}	48/f_{MCK}		–		–		ns
			20 MHz < f_{MCK} ≤ 24 MHz	36/f_{MCK}		–		–		ns
			16 MHz < f_{MCK} ≤ 20 MHz	32/f_{MCK}		–		–		ns
			8 MHz < f_{MCK} ≤ 16 MHz	26/f_{MCK}		–		–		ns
			4 MHz < f_{MCK} ≤ 8 MHz	16/f_{MCK}		16/f_{MCK}		–		ns
			f_{MCK} ≤ 4 MHz	10/f_{MCK}		10/f_{MCK}		10/f_{MCK}		ns
SCKp high-/low-level width	t_{KH2}, t_{KL2}	2.7 V ≤ EV_{DD0} ≤ 3.6 V, 2.3 V ≤ V_b ≤ 2.7 V		t_{KCY2}/2 – 18		t_{KCY2}/2 – 50		t_{KCY2}/2 – 50		ns
		1.8 V ≤ EV_{DD0} < 3.3 V, 1.6 V ≤ V_b ≤ 2.0 V[Note 5]		t_{KCY2}/2 – 50		t_{KCY2}/2 – 50		t_{KCY2}/2 – 50		ns
SIp setup time (to SCKp↑)[Note 6]	t_{SIK2}	2.7 V ≤ EV_{DD0} ≤ 3.6 V, 2.3 V ≤ V_b ≤ 2.7 V		1/f_{MCK} + 20		1/f_{MCK} + 30		1/f_{MCK} + 30		ns
		1.8 V ≤ EV_{DD0} < 3.3 V, 1.6 V ≤ V_b ≤ 2.0 V[Note 5]		1/f_{MCK} + 30		1/f_{MCK} + 30		1/f_{MCK} + 30		ns
SIp hold time (from SCKp↑)[Note 6]	t_{KSI2}			1/f_{MCK} + 31		1/f_{MCK} + 31		1/f_{MCK} + 31		ns
Delay time from SCKp↓ to SOp output[Note 7]	t_{KSO2}	2.7 V ≤ EV_{DD0} ≤ 3.6 V, 2.3 V ≤ V_b ≤ 2.7 V, C_b = 30 pF, R_b = 2.7 kΩ			2/f_{MCK} + 214		2/f_{MCK} + 573		2/f_{MCK} + 573	ns
		1.8 V ≤ EV_{DD0} < 3.3 V, 1.6 V ≤ V_b ≤ 2.0 V[Note 5], C_b = 30 pF, R_b = 5.5 kΩ			2/f_{MCK} + 573		2/f_{MCK} + 573		2/f_{MCK} + 573	ns

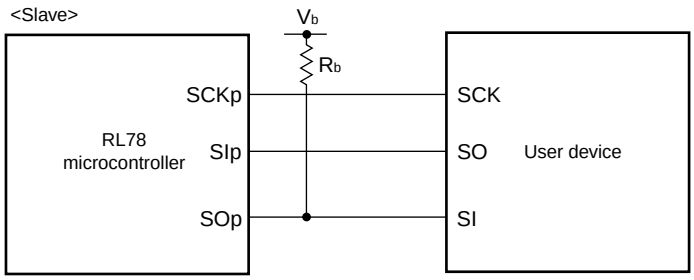
Notes 1. HS is condition of HS (high-speed main) mode.
2. LS is condition of LS (low-speed main) mode.
3. LV is condition of LV (low-voltage main) mode.
4. Transfer rate in the SNOOZE mode : MAX. 1 Mbps
5. Use it with EV_{DD0} ≥ V_b.
6. When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The SIp setup time or SIp hold time becomes "from SCKp↓" when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.
7. When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The delay time to SOp output becomes "from SCKp↑" when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

Caution Select the TTL input buffer for the SIp pin and SCKp pin and the N-ch open drain output (V_{DD} tolerance (When 25- to 48-pin products)/EV_{DD} tolerance (When 64-pin products)) mode for the SOp pin by using port input mode register g (PIMg) and port output mode register g (POMg). For V_{IH} and V_{IL}, see the DC characteristics with TTL input buffer selected.

<R>

(**Remarks** are listed on the next page.)

CSI mode connection diagram (during communication at different potential)



Remarks 1. R_b[Ω]: Communication line (SOp) pull-up resistance, C_b[F]: Communication line (SOp) load capacitance, V_b[V]: Communication line voltage

2. p: CSI number (p = 00, 10, 20), m: Unit number (m = 0, 1), n: Channel number (n = 00, 02, 10), g: PIM and POM number (g = 0, 1)

3. f_{MCK}: Serial array unit operation clock frequency
(Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn).
m: Unit number, n: Channel number (mn = 00, 02, 10))

4. CSI01, CSI11, and CSI21 cannot communicate at different potential. Use other CSI for communication at different potential.

2.5.2 Serial interface IICA

(1) I^2C standard mode

(T_A = –40 to +85°C, 1.6 V ≤ EV_{DD0} ≤ V_{DD} ≤ 3.6 V, V_{SS} = EV_{SS0} = 0 V)

Parameter	Symbol	Conditions	Standard Mode[Note 1]						Unit
			HS[Note 2]		LS[Note 3]		LV[Note 4]		
			MIN.	MAX.	MIN.	MIN.	MAX.	MIN.	
SCLA0 clock frequency	f_{SCL}	2.7 V ≤ EV_{DD0} ≤ 3.6 V	0	100	0	100	0	100	kHz
		1.8 V ≤ EV_{DD0} ≤ 3.6 V	0	100	0	100	0	100	
		1.7 V ≤ EV_{DD0} ≤ 3.6 V	0	100	0	100	0	100	
		1.6 V ≤ EV_{DD0} ≤ 3.6 V	–		0	100	0	100	
Setup time of restart condition	$t_{SU:STA}$	2.7 V ≤ EV_{DD0} ≤ 3.6 V	4.7		4.7		4.7		μs
		1.8 V ≤ EV_{DD0} ≤ 3.6 V	4.7		4.7		4.7		
		1.7 V ≤ EV_{DD0} ≤ 3.6 V	4.7		4.7		4.7		
		1.6 V ≤ EV_{DD0} ≤ 3.6 V	–		4.7		4.7		
Hold time[Note 5]	$t_{HD:STA}$	2.7 V ≤ EV_{DD0} ≤ 3.6 V	4.0		4.0		4.0		μs
		1.8 V ≤ EV_{DD0} ≤ 3.6 V	4.0		4.0		4.0		
		1.7 V ≤ EV_{DD0} ≤ 3.6 V	4.0		4.0		4.0		
		1.6 V ≤ EV_{DD0} ≤ 3.6 V	–		4.0		4.0		
Hold time when SCLA0 = “L”	t_{LOW}	2.7 V ≤ EV_{DD0} ≤ 3.6 V	4.7		4.7		4.7		μs
		1.8 V ≤ EV_{DD0} ≤ 3.6 V	4.7		4.7		4.7		
		1.7 V ≤ EV_{DD0} ≤ 3.6 V	4.7		4.7		4.7		
		1.6 V ≤ EV_{DD0} ≤ 3.6 V	–		4.7		4.7		
Hold time when SCLA0 = “H”	t_{HIGH}	2.7 V ≤ EV_{DD0} ≤ 3.6 V	4.0		4.0		4.0		μs
		1.8 V ≤ EV_{DD0} ≤ 3.6 V	4.0		4.0		4.0		
		1.7 V ≤ EV_{DD0} ≤ 3.6 V	4.0		4.0		4.0		
		1.6 V ≤ EV_{DD0} ≤ 3.6 V	–		4.0		4.0		
Data setup time (reception)	$t_{SU:DAT}$	2.7 V ≤ EV_{DD0} ≤ 3.6 V	250		250		250		ns
		1.8 V ≤ EV_{DD0} ≤ 3.6 V	250		250		250		
		1.7 V ≤ EV_{DD0} ≤ 3.6 V	250		250		250		
		1.6 V ≤ EV_{DD0} ≤ 3.6 V	–		250		250		
Data hold time (transmission)[Note 6]	$t_{HD:DAT}$	2.7 V ≤ EV_{DD0} ≤ 3.6 V	0	3.45	0	3.45	0	3.45	μs
		1.8 V ≤ EV_{DD0} ≤ 3.6 V	0	3.45	0	3.45	0	3.45	
		1.7 V ≤ EV_{DD0} ≤ 3.6 V	0	3.45	0	3.45	0	3.45	
		1.6 V ≤ EV_{DD0} ≤ 3.6 V	–	–	0	3.45	0	3.45	
Setup time of stop condition	$t_{SU:STO}$	2.7 V ≤ EV_{DD0} ≤ 3.6 V	4.0		4.0		4.0		μs
		1.8 V ≤ EV_{DD0} ≤ 3.6 V	4.0		4.0		4.0		
		1.7 V ≤ EV_{DD0} ≤ 3.6 V	4.0		4.0		4.0		
		1.6 V ≤ EV_{DD0} ≤ 3.6 V	–		4.0		4.0		
Bus-free time	t_{BUF}	2.7 V ≤ EV_{DD0} ≤ 3.6 V	4.7		4.7		4.7		μs
		1.8 V ≤ EV_{DD0} ≤ 3.6 V	4.7		4.7		4.7		
		1.7 V ≤ EV_{DD0} ≤ 3.6 V	4.7		4.7		4.7		
		1.6 V ≤ EV_{DD0} ≤ 3.6 V	–		4.7		4.7		

(**Note** and **Remark** are listed on the next page.)

2.9 Dedicated Flash Memory Programmer Communication (UART)

(T_A = –40 to +85°C, 1.8 V ≤ EV_{DD0} ≤ V_{DD} ≤ 3.6 V, V_{SS} = EV_{SS0} = 0 V)

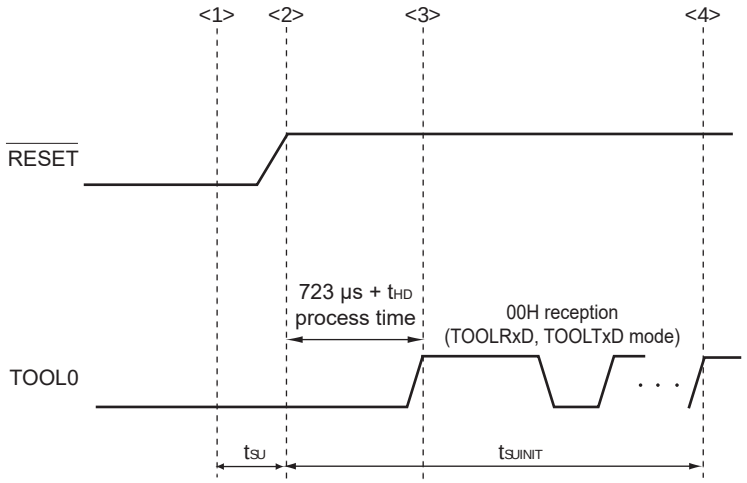
Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Transfer rate		During flash memory programming	115.2 k		1 M	bps

2.10 Timing Specs for Switching Flash Memory Programming Modes

(T_A = –40 to +85°C, 1.8 V ≤ EV_{DD0} ≤ V_{DD} ≤ 3.6 V, V_{SS} = EV_{SS0} = 0 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
How long from when an external reset ends until the initial communication settings are specified	t_{SUINIT}	POR and LVD reset must end before the external reset ends.			100	ms
How long from when the TOOL0 pin is placed at the low level until a external reset ends	t_{SU}	POR and LVD reset must end before the external reset ends.	10			μs
<R> How long the TOOL0 pin must be kept at the low level after an external reset ends (except flash firmware processing time)	t_{HD}	POR and LVD reset must end before the external reset ends.	1			ms

<R>



<1> The low level is input to the TOOL0 pin.
<2> The pins reset ends (POR and LVD reset must end before the external reset ends.).
<3> The TOOL0 pin is set to the high level.
<4> Setting of the flash memory programming mode by UART reception and complete the baud rate setting.

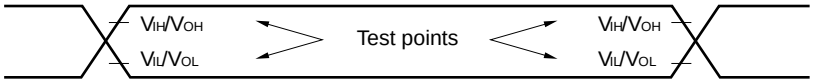
Remark t_{SUINIT}: The segment shows that it is necessary to finish specifying the initial communication settings within 100 ms from when the resets end.

t_{SU}: How long from when the TOOL0 pin is placed at the low level until a external reset ends

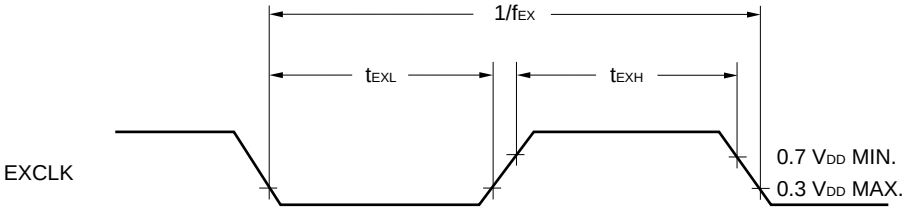
<R> t_{HD}: How long to keep the TOOL0 pin at the low level from when the external resets end (except flash firmware processing time)

AC Timing Test Points

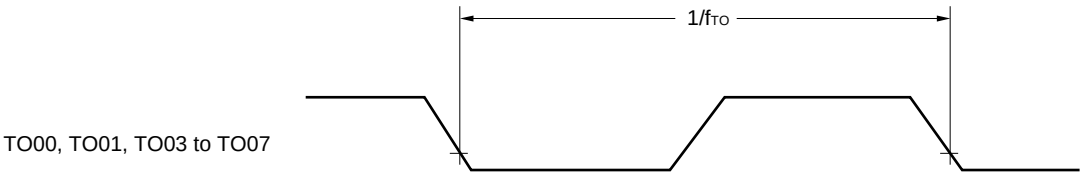
<R>



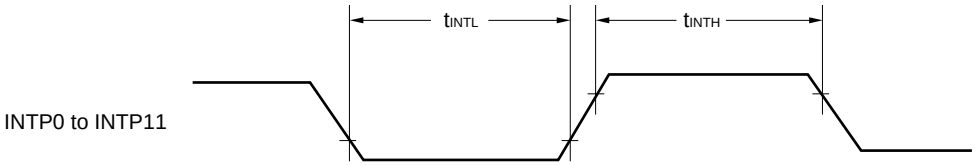
External System Clock Timing



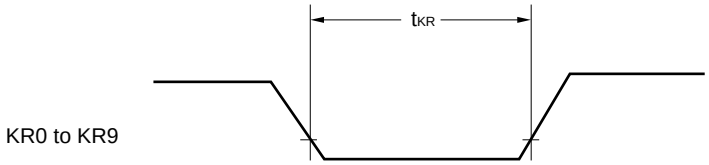
<R> TI/TO Timing



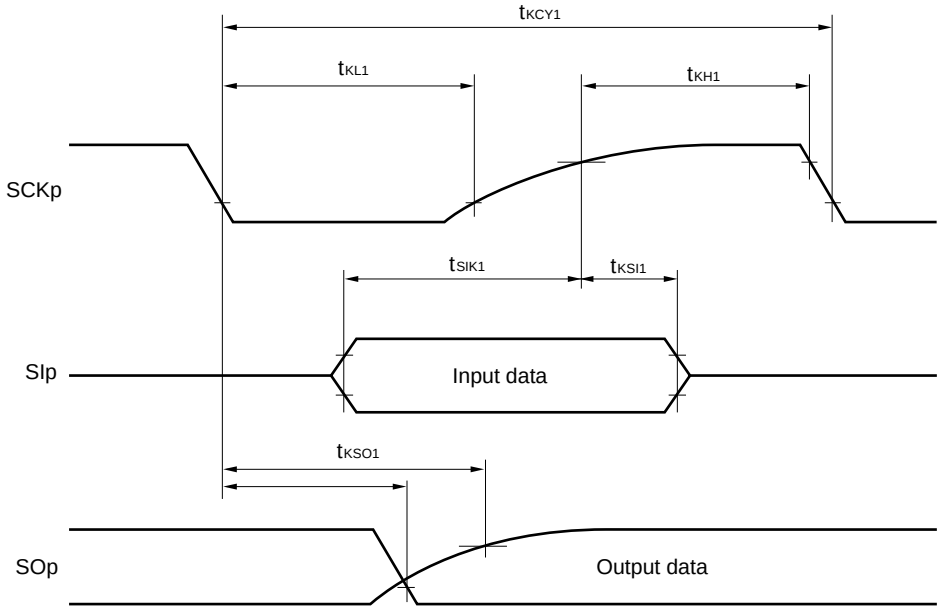
Interrupt Request Input Timing



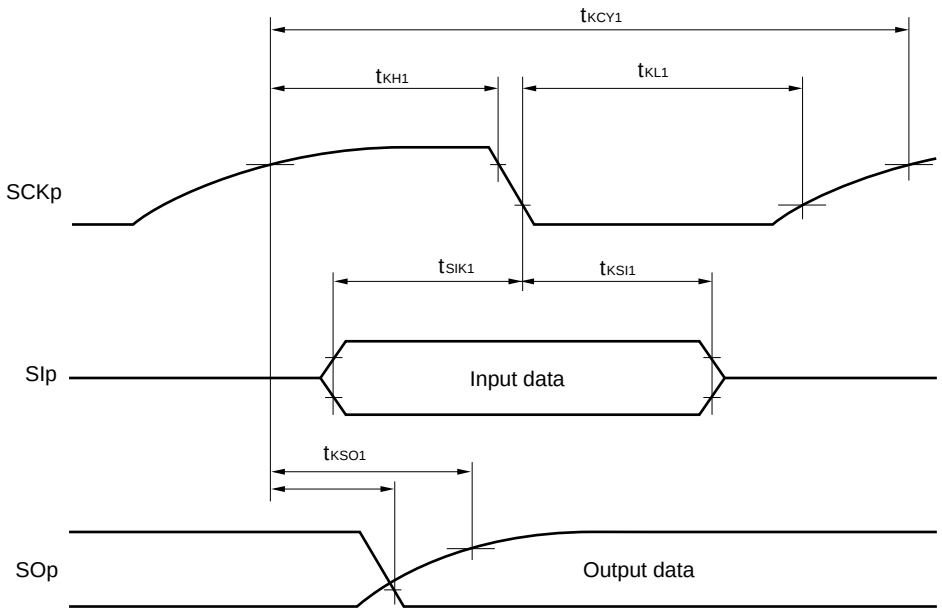
Key Interrupt Input Timing



CSI mode serial transfer timing (master mode) (during communication at different potential)
(When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1.)



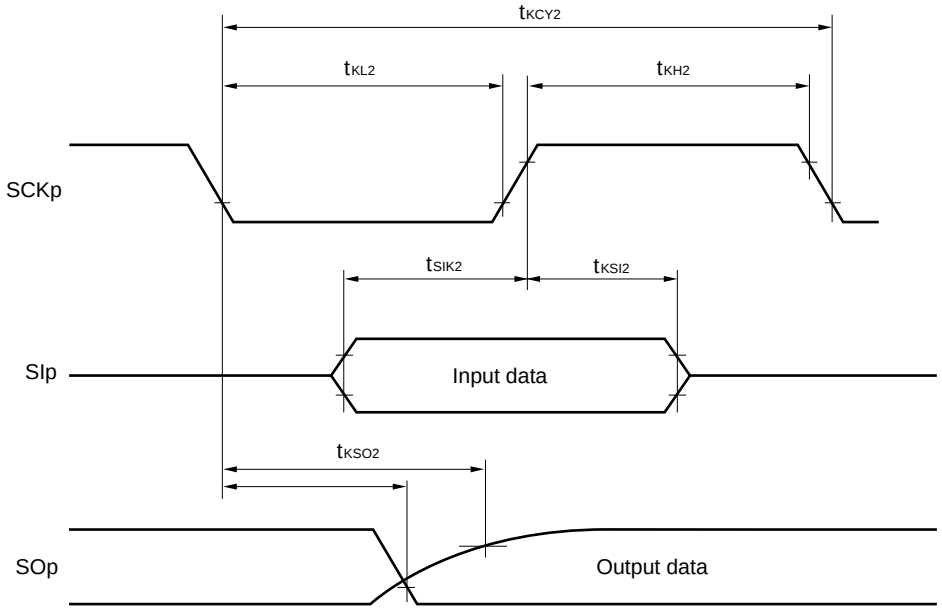
CSI mode serial transfer timing (master mode) (during communication at different potential)
(When DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.)



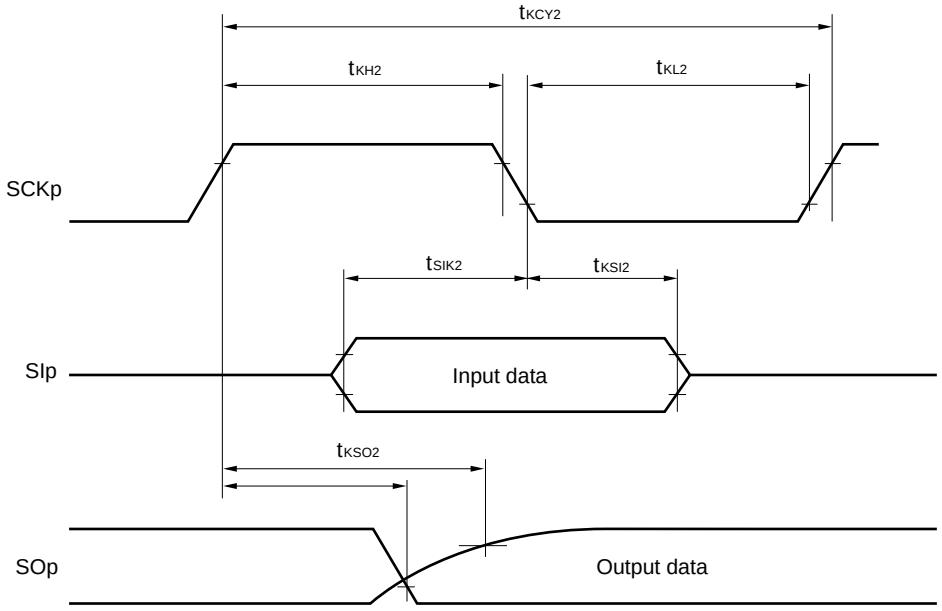
Remarks 1. p: CSI number (p = 00, 10, 20), m: Unit number, n: Channel number (m = 00, 02, 10), g: PIM and POM number (g = 0, 1)

2. CSI01, CSI11, and CSI21 cannot communicate at different potential. Use other CSI for communication at different potential.

CSI mode serial transfer timing (slave mode) (during communication at different potential)
(When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1.)



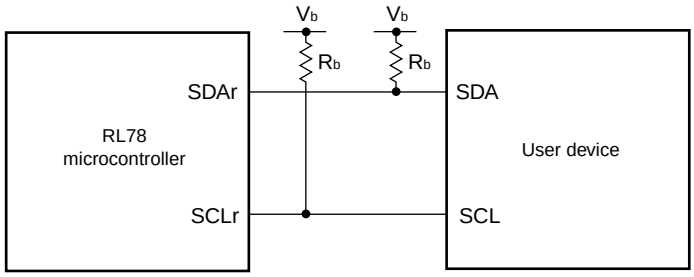
CSI mode serial transfer timing (slave mode) (during communication at different potential)
(When DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.)



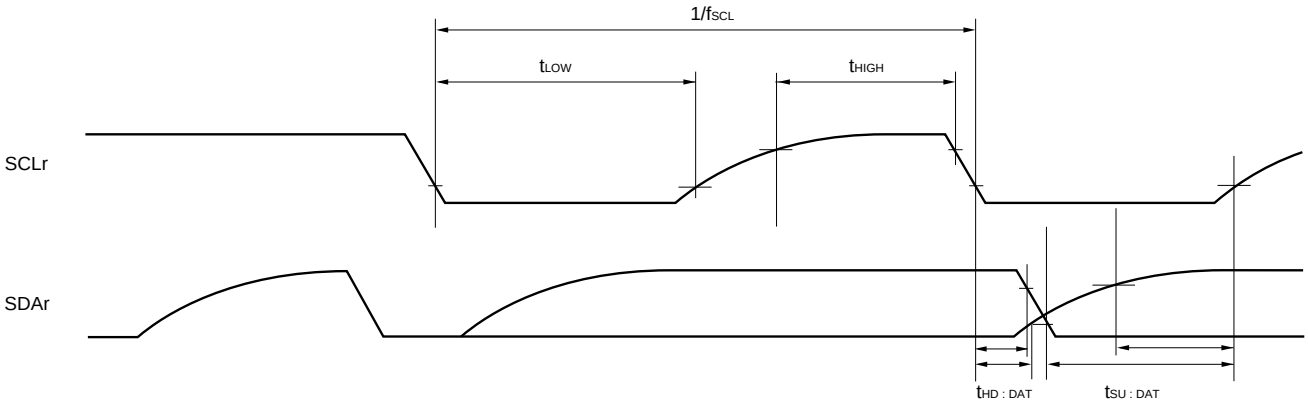
Remarks 1. p: CSI number (p = 00, 10, 20), m: Unit number, n: Channel number (mn = 00, 02, 10), g: PIM and POM number (g = 0, 1)

2. CSI01, CSI11, and CSI21 cannot communicate at different potential. Use other CSI for communication at different potential.

Simplified I^2C mode connection diagram (during communication at different potential)



Simplified I^2C mode serial transfer timing (during communication at different potential)



Remarks 1. R_b[Ω]: Communication line (SDAr, SCLr) pull-up resistance, C_b[F]: Communication line (SDAr, SCLr) load capacitance, V_b[V]: Communication line voltage

2. r: IIC number (r = 00, 10, 20), g: PIM, POM number (g = 0, 1)

3. f_{MCK}: Serial array unit operation clock frequency
(Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number, n: Channel number (mn = 00, 02, 10)

4. IIC01, IIC11, and IIC21 cannot communicate at different potential. Use IIC00, IIC10, or IIC20 for communication at different potential.

3.6 Analog Characteristics

3.6.1 A/D converter characteristics

Division of A/D Converter Characteristics

Reference voltag / Input channel	Reference voltage (+) = AV_{REFP} Reference voltage (–) = AV_{REFM}	Reference voltage (+) = AV_{DD} Reference voltage (–) = AV_{SS}	Reference voltage (+) = Internal refrence voltage Reference voltage (–) = AV_{SS}
High-accuracy channel; ANI0 to ANI12 (input buffer power supply: AV_{DD})	See **3.6.1 (1)**	See **3.6.1 (2)**	See **3.6.1 (5)**
Standard channel; ANI16 to ANI30 (input buffer power supply: V_{DD} or EV_{DD0})	See **3.6.1 (3)**	See **3.6.1 (4)**	
Temperature sensor, internal reference voltage output	See **3.6.1 (3)**	See **3.6.1 (4)**	–

<R> **(1) When reference voltage (+) = AV_{REFP}/ANI0 (ADREFP1 = 0, ADREFP0 = 1), reference voltage (–) = AV_{REFM}/ANI1 (ADREFM = 1), target for conversion: ANI2 to ANI12**

(T_A = –40 to +105°C, 2.4 V ≤ AV_{REFP} ≤ AV_{DD} ≤ V_{DD} ≤ 3.6 V, V_{SS} = 0 V, AV_{SS} = 0 V, Reference voltage (+) = AV_{REFP}, Reference voltage (–) = AV_{REFM} = 0 V)

Parameter	Symbol	Conditions		MIN.	TYP.	MAX.	Unit
Resolution	R_{ES}		2.4 V ≤ AV_{REFP} ≤ AV_{DD} ≤ 3.6 V	8.		12.	bit
Overall error[Note]	AINL	12-bit resolution	2.4 V ≤ AV_{REFP} ≤ AV_{DD} ≤ 3.6 V			±6.0	LSB
Conversion time	t_{CONV}	ADTYP = 0, 12-bit resolution	2.4 V ≤ AV_{REFP} ≤ AV_{DD} ≤ 3.6 V	3.375			μs
Zero-scale error[Note]	E_{ZS}	12-bit resolution	2.4 V ≤ AV_{REFP} ≤ AV_{DD} ≤ 3.6 V			±4.5	LSB
Full-scale error[Note]	E_{FS}	12-bit resolution	2.4 V ≤ AV_{REFP} ≤ AV_{DD} ≤ 3.6 V			±4.5	LSB
Integral linearity error[Note]	ILE	12-bit resolution	2.4 V ≤ AV_{REFP} ≤ AV_{DD} ≤ 3.6 V			±2.0	LSB
Differential linearity error[Note]	DLE	12-bit resolution	2.4 V ≤ AV_{REFP} ≤ AV_{DD} ≤ 3.6 V			±1.5	LSB
Analog input voltage	V_{AIN}			0		AV_{REFP}	V

Note Excludes quantization error (±1/2 LSB).

<R> **(5) When reference voltage (+) = Internal reference voltage (1.45 V) (ADREFP1 = 1, ADREFP0 = 0), reference voltage (–) = AV_{SS} (ADREFM = 0), target for conversion: ANI0 to ANI12, ANI16 to ANI30**

(T_A = –40 to +105°C, 2.4 V ≤ V_{DD} ≤ 3.6 V, 2.4 V ≤ EV_{DD} ≤ V_{DD}, 2.4 V ≤ AV_{DD} ≤ V_{DD}, V_{SS} = EV_{SS0} = 0 V, AV_{SS} = 0 V, Reference voltage (+) = Internal reference voltage, Reference voltage (–) = AV_{SS} = 0 V, HS (high-speed main) mode)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Resolution	R_{ES}			8		bit
Conversion time	t_{CONV}	8-bit resolution	16.0			μs
Zero-scale error[Note]	E_{ZS}	8-bit resolution			±4.0	LSB
Integral linearity error[Note]	ILE	8-bit resolution			±2.0	LSB
Differential linearity error[Note]	DLE	8-bit resolution			±2.5	LSB
Reference voltage (+)	$AV_{REF(+)}$	= Internal reference voltage (V_{BGR})	1.38	1.45	1.50	V
Analog input voltage	V_{AIN}		0		V_{BGR}	V

Note Excludes quantization error (±1/2 LSB).

3.6.2 Temperature sensor, internal reference voltage output characteristics

(T_A = –40 to +105°C, 2.4 V ≤ V_{DD} ≤ 3.6 V, V_{SS} = 0 V, HS (high-speed main) mode)

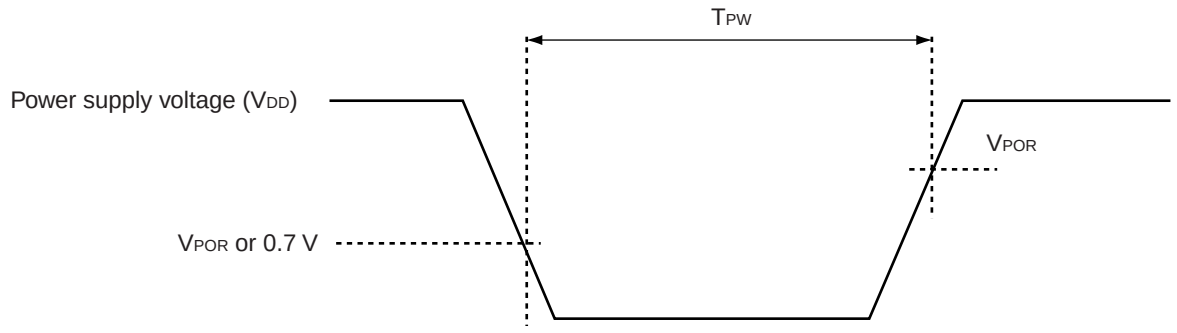
Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Temperature sensor output voltage	V_{TMPS25}	Setting ADS register = 80H, T_A = +25°C		1.05		V
Internal reference voltage	V_{BGR}	Setting ADS register = 81H	1.38	1.45	1.5	V
Temperature coefficient	F_{VTMPS}	Temperature sensor output voltage that depends on the temperature		–3.6		mV/°C
Operation stabilization wait time	t_{AMP}		10			μs

3.6.3 POR circuit characteristics

(T_A = –40 to +105°C, V_{SS} = 0 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Detection voltage	V_{POR}	Power supply rise time	1.45	1.51	1.57	V
	V_{PDR}	Power supply fall time	1.44	1.50	1.56	V
Minimum pulse width[Note]	T_{PW}		300			μs

Note This is the time required for the POR circuit to execute a reset when V_{DD} falls below V_{PDR}. When the microcontroller enters STOP mode or if the main system clock (f_{MAIN}) has been stopped by setting bit 0 (HIOSTOP) and bit 7 (MSTOP) of the clock operation status control register (CSC), this is the time required for the POR circuit to execute a reset before V_{DD} rises to V_{POR} after having fallen below 0.7 V.



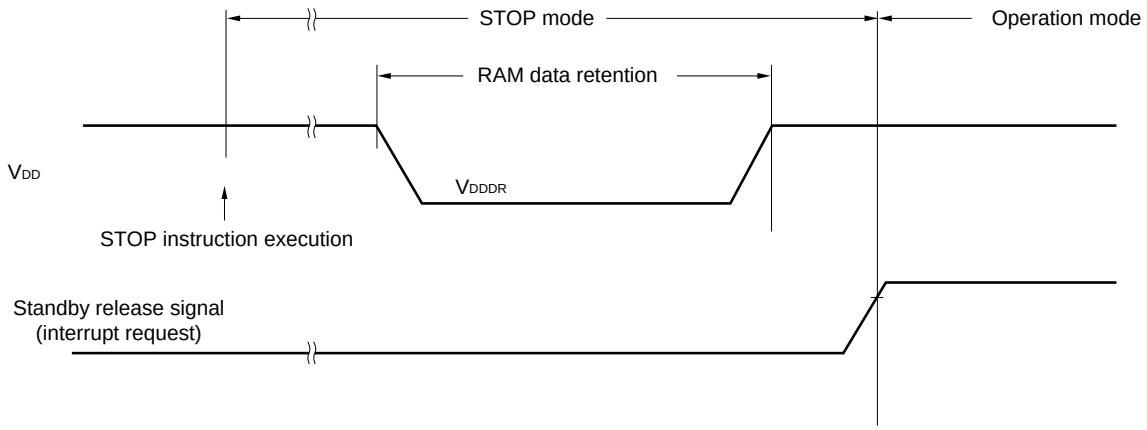
<R> 3.7 RAM Data Retention Characteristics

<R> **(T_A = –40 to +105°C, V_{SS} = 0 V)**

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Data retention supply voltage	V_{DDDR}		1.44[Note]		3.6	V

<R> **Note** This depends on the POR detection voltage. For a falling voltage, data in RAM are retained until the voltage reaches the level that triggers a POR reset but not once it reaches the level at which a POR reset is generated.

<R>



3.8 Flash Memory Programming Characteristics

(T_A = –40 to +105°C, 2.4 V ≤ V_{DD} ≤ 3.6 V, V_{SS} = 0 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
CPU/peripheral hardware clock frequency	f_{CLK}	2.4 V ≤ V_{DD} ≤ 3.6 V	1		32	MHz
Number of code flash rewrites[Notes 1, 2, 3]	C_{erwr}	Retained for 20 years T_A = 85°C	1,000			Times
Number of data flash rewrites[Notes 1, 2, 3]		Retained for 1 years T_A = 25°C		1,000,000		
		Retained for 5 years T_A = 85°C	100,000			
		Retained for 20 years T_A = 85°C	10,000			

Notes 1. 1 erase + 1 write after the erase is regarded as 1 rewrite.
The retaining years are until next rewrite after the rewrite.

2. When using flash memory programmer and Renesas Electronics self programming library

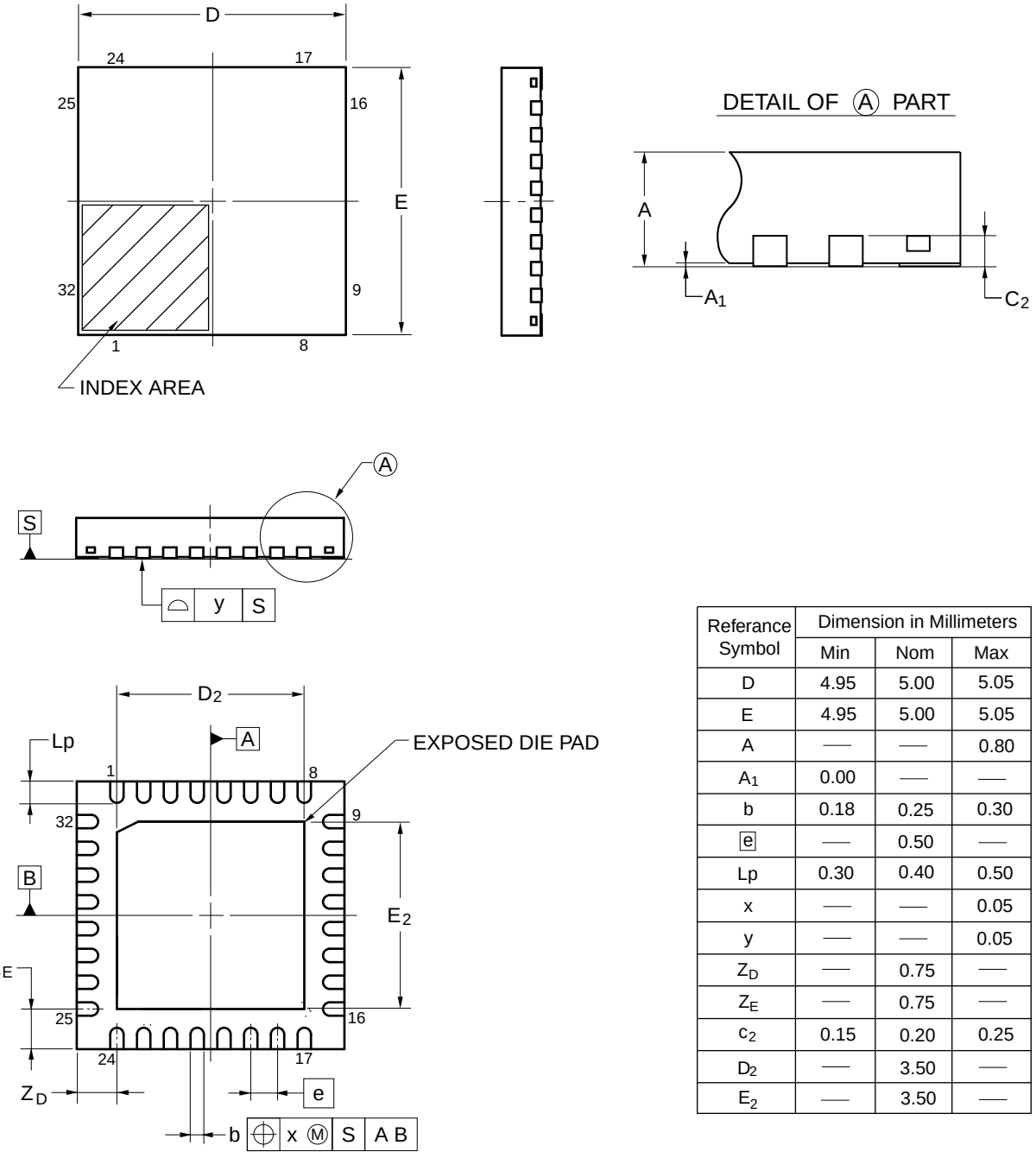
3. These are the characteristics of the flash memory and the results obtained from reliability testing by Renesas Electronics Corporation.

<R> **4.** This temperature is the average value at which data are retained.

4.2 32-pin products

R5F10EBAANA, R5F10EBCANA, R5F10EBDANA, R5F10EBEANA
R5F10EBAGNA, R5F10EBCGNA, R5F10EBDGNA, R5F10EBEGNA

JEITA Package code	RENESAS code	Previous code	MASS(TYP.)[g]
P-HWQFN32-5x5-0.50	PWQN0032KB-A	P32K8-50-3B4-5	0.06

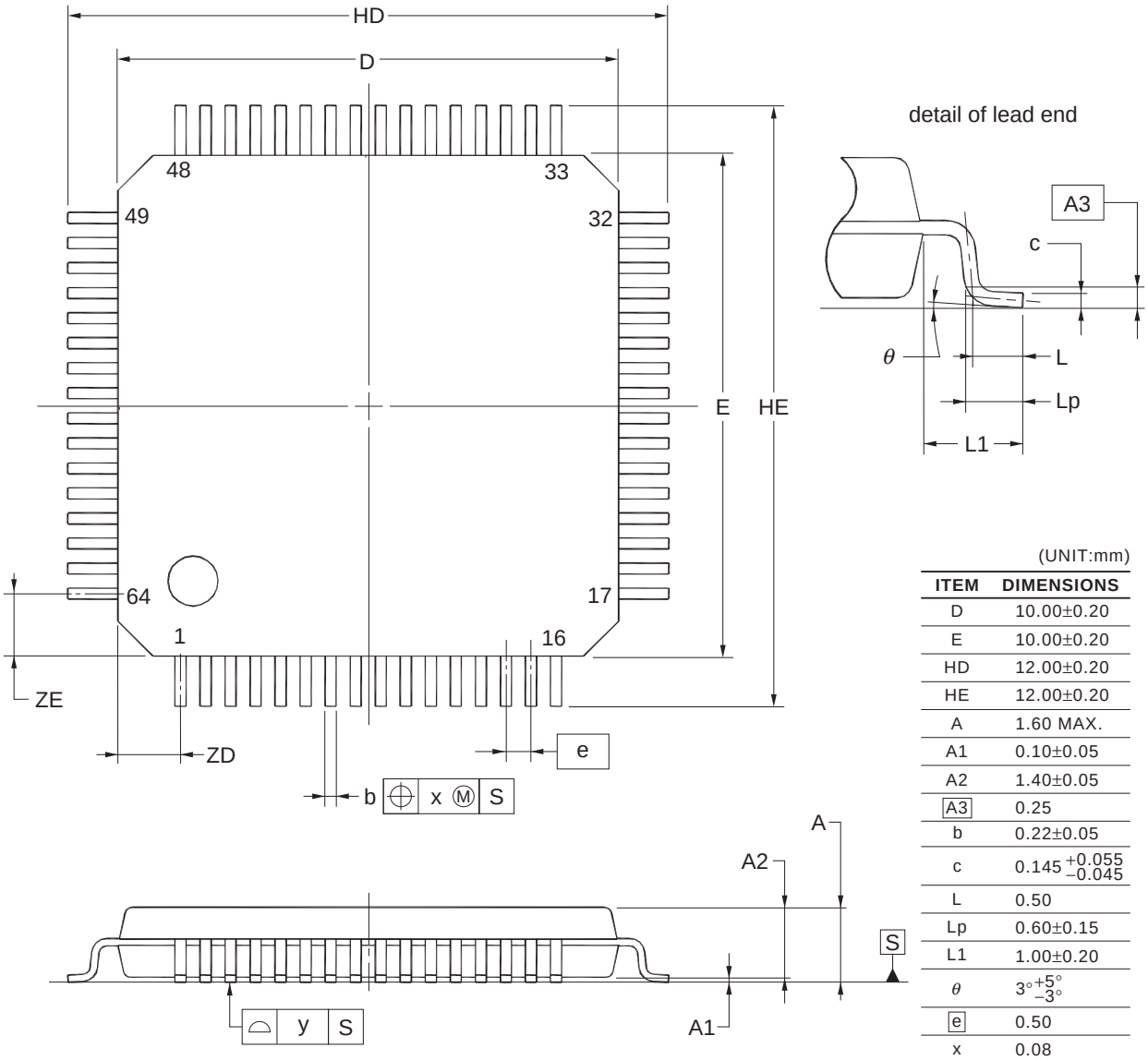


Referance Symbol	Dimension in Millimeters		
	Min	Nom	Max
D	4.95	5.00	5.05
E	4.95	5.00	5.05
A	—	—	0.80
A_1	0.00	—	—
b	0.18	0.25	0.30
e	—	0.50	—
Lp	0.30	0.40	0.50
x	—	—	0.05
y	—	—	0.05
Z_D	—	0.75	—
Z_E	—	0.75	—
c_2	0.15	0.20	0.25
D_2	—	3.50	—
E_2	—	3.50	—

4.4 64-pin products

R5F10ELCAFB, R5F10ELDAFB, R5F10ELEAFB
R5F10ELCGFB, R5F10ELDGFB, R5F10ELEGFB

JEITA Package Code	RENESAS Code	Previous Code	MASS (TYP.) [g]
P-LFQFP64-10x10-0.50	PLQP0064KF-A	P64GB-50-UEU-2	0.35



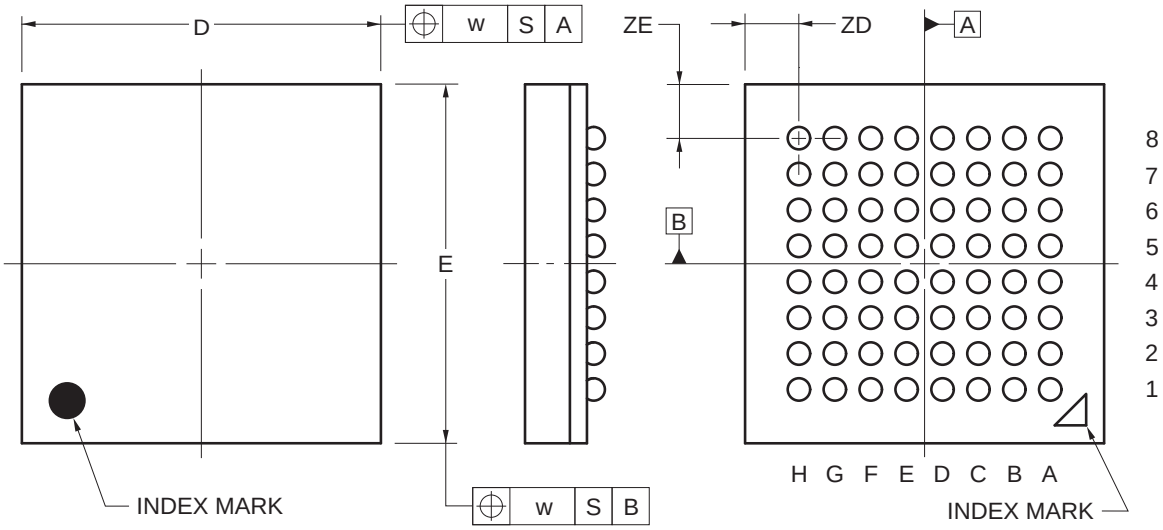
(UNIT:mm)

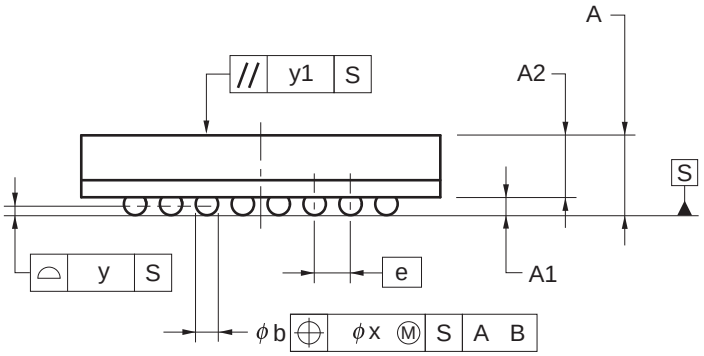
ITEM	DIMENSIONS
D	10.00±0.20
E	10.00±0.20
HD	12.00±0.20
HE	12.00±0.20
A	1.60 MAX.
A1	0.10±0.05
A2	1.40±0.05
A3	0.25
b	0.22±0.05
c	$0.145^{+0.055}_{-0.045}$
L	0.50
Lp	0.60±0.15
L1	1.00±0.20
θ	$3^{\circ}{}^{+5^{\circ}}_{-3^{\circ}}$
e	0.50
x	0.08
y	0.08
ZD	1.25
ZE	1.25

NOTE
Each lead centerline is located within 0.08 mm of its true position at maximum material condition.

R5F10ELCABG, R5F10ELDABG, R5F10ELEABG

JEITA Package Code	RENESAS Code	Previous Code	MASS (TYP.) [g]
P-VFBGA64-4x4-0.40	PVBG0064LA-A	P64F1-40-AA2-2	0.03





(UNIT:mm)

ITEM	DIMENSIONS
D	4.00±0.10
E	4.00±0.10
w	0.15
A	0.89±0.10
A1	0.20±0.05
A2	0.69
e	0.40
b	0.25±0.05
x	0.05
y	0.08
y1	0.20
ZD	0.60
ZE	0.60